

| Wavelength range | Type | Technology | Electrodes |
|------------------|--------|------------|------------------|
| Infrared | Planar | InGaAs/InP | Both on top side |

| | |
|--|--|
| | typ. dimensions in μm |
| | <p><u>typ. thickness</u> 330 (± 20) μm</p> <p><u>top side*</u> bond gold 1.0 μm</p> <p><u>rear side</u> no metalization</p> <p>* Bond pad assignment: Pos. 1 - Anode Pos. 2 - Cathode</p> |
| | <p>Description Broadband photodiode with maximum response in the NIR-region, no rear side metalization</p> <p>Applications Optical communications, safety equipment, light barriers</p> |

Miscellaneous Parameters

$T_{\text{amb}} = 25^\circ\text{C}$, unless otherwise specified

| Parameter | Test conditions | Symbol | Value | Unit |
|----------------------------------|-----------------------------------|------------------|-------------|------------------|
| Active area | | A | 0.032 | mm^2 |
| Operating temperature range | | T_{amb} | -40 to +125 | $^\circ\text{C}$ |
| Storage temperature range | | T_{stg} | -40 to +125 | $^\circ\text{C}$ |
| Temperature coefficient of I_D | $T = -40 \dots 120^\circ\text{C}$ | $T_C(I_D)$ | 7.4 | %/K |

Optical and Electrical Characteristics

$T_{\text{amb}} = 25^\circ\text{C}$, unless otherwise specified

| Parameter | Test conditions | Symbol | Min | Typ | Max | Unit |
|---------------------------------------|-----------------------------|-----------------------|-----|-----------------------|------|--|
| Forward voltage | $I_F = 10 \text{ mA}$ | V_F | | 1.7 | | V |
| Breakdown voltage ²⁾ | $I_R = 10 \mu\text{A}$ | V_R | 5 | | | V |
| Sensitivity range at 10 % | $V_R = 0 \text{ V}$ | λ | 800 | | 1750 | nm |
| Spectral bandwidth at 50 % | $V_R = 0 \text{ V}$ | $\Delta\lambda_{0,5}$ | | 680 | | nm |
| Responsivity at 1300 nm ¹⁾ | $V_R = 0 \text{ V}$ | S_λ | | 0.9 | | A/W |
| Dark current | $V_R = 5 \text{ V}$ | I_D | | 30 | 200 | pA |
| Shunt resistance | $V_R = 10 \text{ mV}$ | R_{SH} | 3 | 5 | | G Ω |
| Noise equivalent power | $\lambda = 1300 \text{ nm}$ | NEP | | 4.0×10^{-15} | | $\text{W}/\sqrt{\text{Hz}}$ |
| Specific detectivity | $\lambda = 1300 \text{ nm}$ | D^* | | 4.5×10^{12} | | $\text{cm} \cdot \sqrt{\text{Hz}} \cdot \text{W}^{-1}$ |
| Junction capacitance | $V_R = 0 \text{ V}$ | C_J | | 11 | | pF |

¹⁾ measured on bare chip on TO-18 header

²⁾ for information only

Labeling

| Type | Typ. I_D [pA] | Typ. S_λ [A/W] | Lot N° | Quantity |
|-----------------|-----------------|------------------------|--------|----------|
| EPC-1300-0.22-3 | | | | |

Packing: Chips on adhesive film with wire-bond side on top

*Note: All measurements carried out with *EPIGAP* equipment

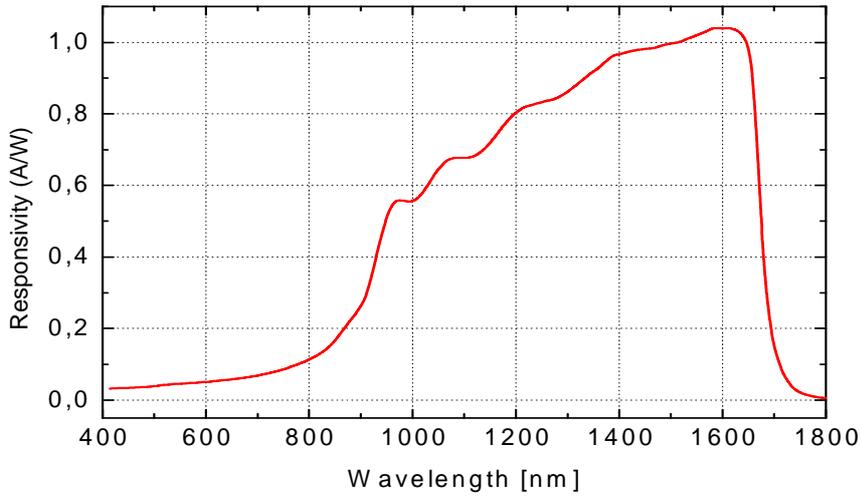
We reserve the right to make changes to improve technical design and may do so without further notice.

Parameters can vary in different applications. All operating parameters must be validated for each application by the customers themselves.

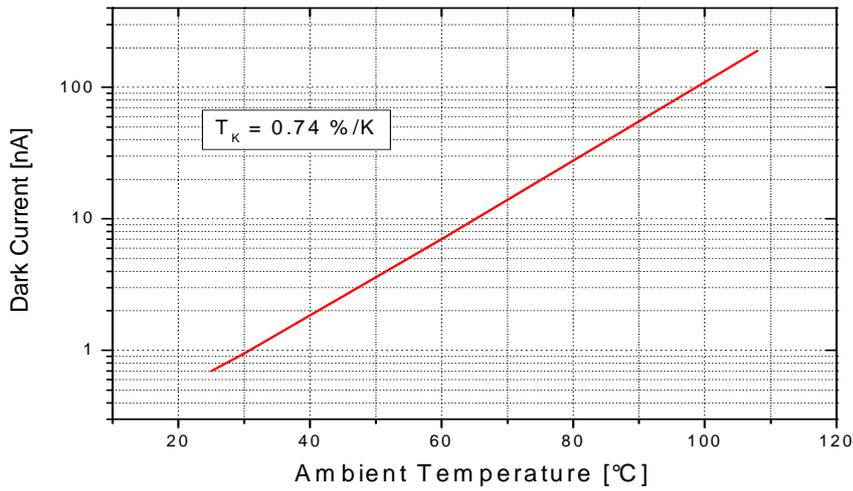
EPIGAP Optoelektronik GmbH, D-12555 Berlin, Köpenicker Str.325 b, Haus 201

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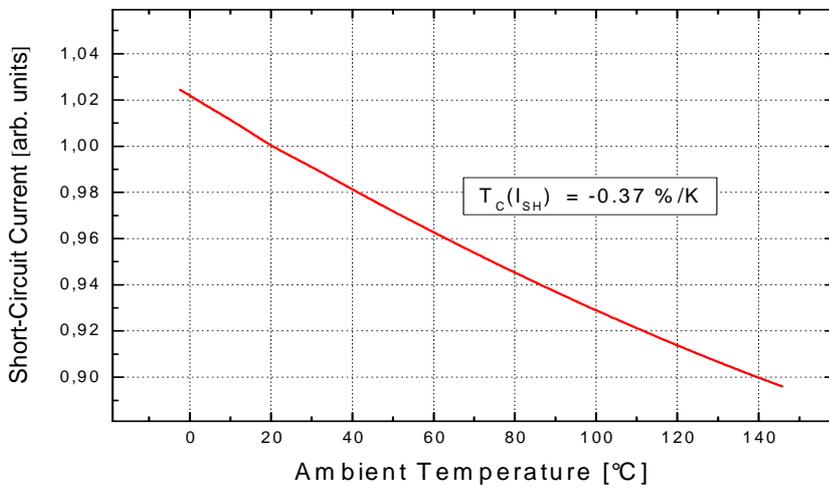
Typical Optical Responsivity



Dark Current vs. Ambient Temperature



Short-Circuit Current vs. Ambient Temperature [T_c]



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